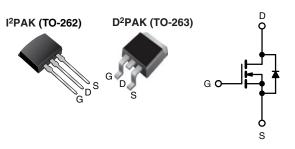
# IRF840LCS, IRF840LCL, SiHF840LCS, SiHF840LCL

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# Power MOSFET



N-Channel MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	500				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.85				
Q <sub>g</sub> max. (nC)	39				
Q <sub>gs</sub> (nC)	10				
Q <sub>gd</sub> (nC)	19				
Configuration	Single				

### **FEATURES**

- Ultra low gate charge
- Reduced gate drive requirement
- Enhanced 30 V V<sub>GS</sub> rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Extremely high frequency operation
- Repetitive avalanche rated
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

HALOGEN

FREE

### DESCRIPTION

This series of low charge power MOSFETs achieve significantly lower gate charge then conventional Power MOSFETs. Utilizing the new LCDMOS (low charge device Power MOSFETs) technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge Power MOSFETs.

These device improvements combined with the proven ruggedness and reliability that characterize Power MOSFETs offer the designer a new power transistor standard for switching applications.

ORDERING INFORMATION					
Package	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)			
Lead (Pb)-free and Halogen-free	SiHF840LCS-GE3	SiHF840LCL-GE3			
Lead (Pb)-free	IRF840LCSPbF	IRF840LCLPbF			
Leau (FD)-IIee	IRF840LCSTRRPBF	-			

#### Note

See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	500	V	
Gate-Source Voltage			$V_{GS}$	± 30	- V	
Continuous Prain Current	V at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$	I_	8.0		
Continuous Drain Current $V_{GS}$ at 10 V $T_{C} = 100$		T <sub>C</sub> = 100 °C	I <sub>D</sub>	5.1	Α	
Pulsed Drain Current a, e			I <sub>DM</sub>	28		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy b, e			E <sub>AS</sub>	510	mJ	
Avalanche Current <sup>a</sup>			I <sub>AR</sub>	8.0	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Daway Dissination	T <sub>C</sub> =	: 25 °C	ם	125	10/	
Maximum Power Dissipation $T_A = 25 ^{\circ}\text{C}$		25 °C	$P_{D}$	3.1	W	
Peak Diode Recovery dV/dt c, e			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering Recommendations (Peak temperature) <sup>d</sup>	For	10 s		300	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11) b. Starting T<sub>J</sub> = 25 °C, L = 14 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 8.0 A (see fig. 12) c. I<sub>SD</sub>  $\leq$  8.0 A, dI/dt  $\leq$  100 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C

- 1.6 mm from case
- Uses IRF840LC, SiHF840LC data and test conditions

S21-0901-Rev. D, 30-Aug-2021 Document Number: 91068



# IRF840LCS, IRF840LCL, SiHF840LCS, SiHF840LCL

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	1.0		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material)

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static					I.	I.	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA °	-	0.63	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zava Cata Valtaga Dvain Cuvvant		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.8 A <sup>b</sup>	-	-	0.85	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 4.8 A <sup>b</sup>	4.0	-		S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	1100		
Output Capacitance	C <sub>oss</sub>	1	$V_{DS} = 25 \text{ V},$	-	170	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	0 MHz, see fig. 5 <sup>c</sup>	-	18	-	
Total Gate Charge	$Q_g$			-	-	39	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	V <sub>GS</sub> = 10 V		-	10	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	occing. o and to	-	-	19	1
Turn-On Delay Time	t <sub>d(on)</sub>		<u> </u>	-	12		
Rise Time	t <sub>r</sub>	$V_{DD} = 250 \text{ V}, I_D = 8.0 \text{ A}, \\ R_g = 9.1 \ \Omega, R_D = 30 \ \Omega, \text{ see fig. } 10^{\text{ b, c}}$		-	25		ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	27	-	
Fall Time	t <sub>f</sub>			-	19	-	
Gate Input Resistance	R <sub>g</sub>	f = 1	MHz, open drain	0.7	-	3.7	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET s showing	_   D	-	-	8.0	^
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		=	-	28	- A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	$I_{S} = 8.0 \text{ A}, V_{GS} = 0 \text{ V}^{\text{ b}}$	-	-	2.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 00 1	0.0 4 -11/-14 - 4.00 47 - 5.0	-	490	740	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  {}^{\circ}\text{C}$ , $I_F = 8.0  \text{A}$ , $dI/dt = 100  \text{A/}\mu\text{s}^{\text{b, c}}$		-	3.0	4.5	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq 300 \ \mu s$ ; duty cycle  $\leq 2 \ \%$
- c. Uses SiHF840LC data and test conditions

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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

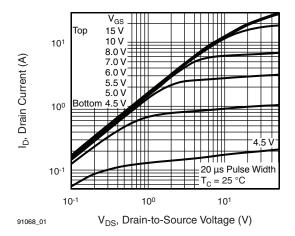


Fig. 1 - Typical Output Characteristics

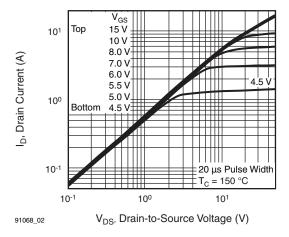


Fig. 2 - Typical Output Characteristics

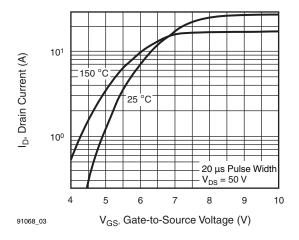


Fig. 3 - Typical Transfer Characteristics

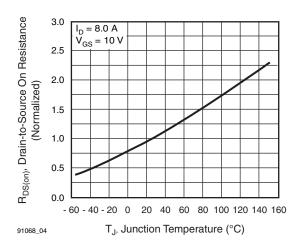


Fig. 4 - Normalized On-Resistance vs. Temperature

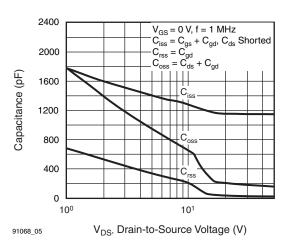


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

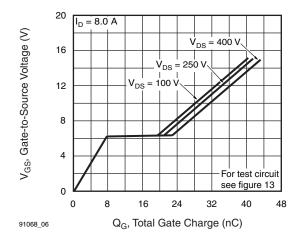


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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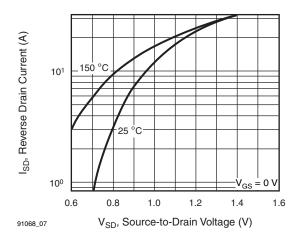


Fig. 7 - Typical Source-Drain Diode Forward Voltage

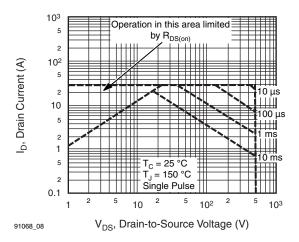


Fig. 8 - Maximum Safe Operating Area

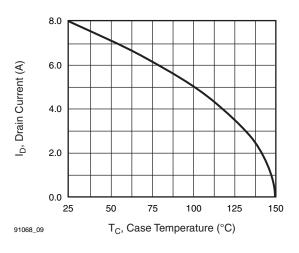


Fig. 9 - Maximum Drain Current vs. Case Temperature

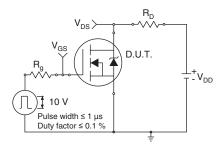


Fig. 10a - Switching Time Test Circuit

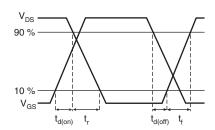


Fig. 10b - Switching Time Waveforms

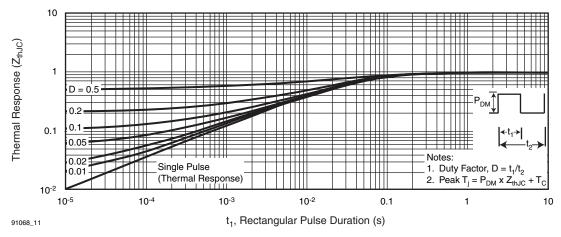


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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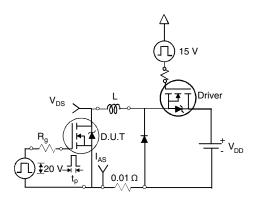


Fig. 12a - Unclamped Inductive Test Circuit

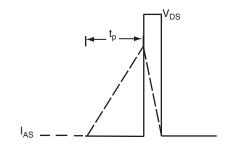


Fig. 12b - Unclamped Inductive Waveforms

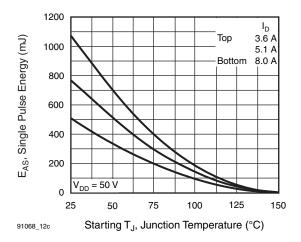


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

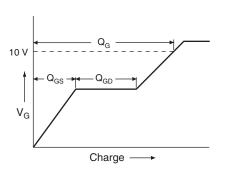


Fig. 13a - Basic Gate Charge Waveform

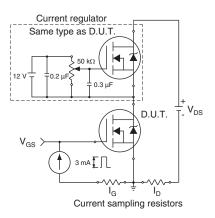
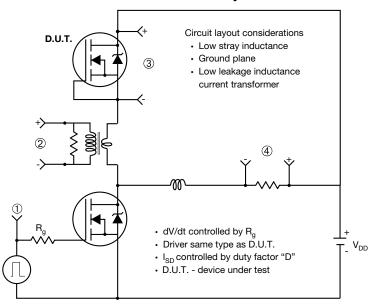


Fig. 13b - Gate Charge Test Circuit

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### Peak Diode Recovery dV/dt Test Circuit



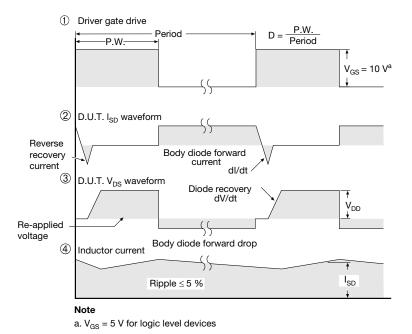


Fig. 14 - For N-Channel

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### **TO-263AB (HIGH VOLTAGE)**







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	ı
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	-	0.070
L3	0.25	BSC	0.010	BSC
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

DWG: 5970

#### Notes

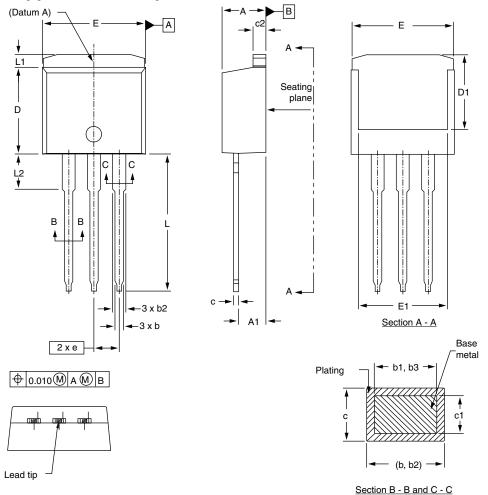
- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





# I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	2.54 BSC		BSC
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08





# RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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